

FOUR PROBE SET-UP



Resistivity of semiconductor by four probe method at different temperatures and determination of the band-gap:

The Four Probe Method is one of the standard and most widely used method for the measurement of resistivity. In its useful form, the four probes are collinear. The error due to contact resistance, which is significant in the electrical measurement on semiconductors, is avoided by the use of two extra contacts (probes) between the current contacts. In this arrangement the contact resistance may all be high compare to the sample resistance, but as long as the resistance of the sample and contact resistance's are small compared with the effective resistance of the voltage measuring device (potentiometer, electrometer or electronic voltmeter), the measured value will remain unaffected. Because of pressure contacts, the arrangement is also specially useful for quick measurement on different samples or sampling different parts of the sample.

DESCRIPTION OF THE EXPERIMENTAL SET-UP:

❖ Probes Arrangement:

It has four individually spring loaded probes. The probes are collinear and equally spaced. The probes are mounted in a teflon bush, which ensure a good electrical insulation between the probes. A teflon spacer near the tips is also provided to keep the probes at equal distance. The probe arrangement is mounted in a suitable stand, which also holds the sample plate. To ensure the correct measurement of sample temperature, the RTD is embedded in the sample plate just below the sample. This stand also serves as the lid of temperature controlled oven. Proper leads are provided for the current and voltage measurement.

❖ Sample:

Germanium crystal is in the form of chip.

❖ Oven:

This is high quality temperature controlled oven suitable for Four Probe Set-up. The oven has been designed for fast heating and cooling rates, which enhances the effectiveness of the controller.

❖ Four Probe Set-Up, DFP-03:

The set-up consists of three units housed in the same cabinet.

• Oven Controller

Platinum RTD (A class) has been used for sensing the temperature. A Wheatstone bridge and an instrumentation amplifier are used for signal conditioning. Feedback circuit ensures offset and linearity trimming and a fast accurate control of the oven temperature.

Specifications of the Oven

Temperature Range	: Ambient to 473K
Resolution	: 1K
Stability	: $\pm 0.5K$
Measurement Accuracy	: $\pm 1K$ □(typical)

Oven : Specially designed for Four Probe Set-Up
 Sensor : RTD (A class)
 Display : 3½ digit, 7 segment LED with auto polarity and decimal indication
 Power : 150W

• **Multirange Digital Voltmeter**

In this unit, intersil 3½ digit single chip A/D Converter ICL 7107 has been used. It has accuracy, auto zero to less than 10 µV, zero drift-less than 1µV/°C input bias current of 10 pA and roll over error of less than one count. Since the use of internal reference causes the degradation in performance due to internal heating, an external reference has been used.

Specifications

Range : X1 (0-200mV) & X10 (0-2V)
 Resolution : 100µV at X 1 range
 Accuracy : ±0.1% of reading ±1 digit
 Display : 3½ digit, 7 segment LED with auto polarity and decimal indication
 Overload indicator : Sign of 1 on the left blanking of other digits.

• **Constant Current Generator**

It is an IC regulated current generator to provide a constant current to the outer probes irrespective of the changing resistance of the sample due to change in temperatures. The basic scheme is to use the feedback principle to limit the load current of the supply to preset maximum value. Variations in the current are achieved by a potentiometer included for that purpose. The supply is a highly regulated and practically ripple free DC source. The current is measured by the digital panel meter.

Specifications

Open circuit Voltage : 18 V
 Current Rating : 0 - 20 mA
 Resolution : 10µA
 Accuracy : ±0.25% of the reading ±1 digit
 Load regulation : 0.05% for 0 to full load
 Line Regulation : 0.05% for 10% changes

The experimental set-up is complete in all respect
 Typical results obtained from this set-up are shown in the graph.

